ANALOG DEVICES

Low V$_{IN}$, Quad 8A Silent Switcher µModule Regulator

FEATURES

- **Quad Output Step-Down µModule® Regulator with Configurable 8A Output Array**
- **Ultralow Noise Silent Switcher®2 Architecture**
- **CISPR32 Class B Compliant**
- Input Voltage Range: 2.5V to 5.5V
- Output Voltage Range: 0.5V to 3.6V
- 8A DC Output Current, Each Channel
- Parallelable for Higher Output Current
- ±1.5% Maximum Total DC Output Voltage Accuracy
- Selectable Switching Frequency: 1MHz to 5MHz
- Power Good Indicator
- Die Temperature Monitoring
- 6mm × 12mm × 3.54mm Land Grid Array (LGA) with Presolder Package
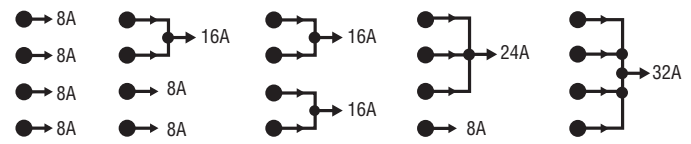
APPLICATIONS

- Optical Communications
- Multi-Rail Point-of-Load Regulation
- Field Programmable Gate Arrays (FPGAs), Digital Signal Processing (DSPs) and Application Specific Integrated Circuits (ASICs) Applications
- Telecom, Datacom, Networking System

DESCRIPTION

The LTM®4710-1 is a quad DC/DC step-down µModule (micromodule) regulator with 8A per output. The package includes the switching controllers, the power MOSFETs, inductors and all supported components. Operating over an input voltage range of 2.5V to 5.5V. Channel 1's output voltage can be set by only one external resistor, where the outputs for channel 2, channel 3, and channel 4 can be set by two external resistors. All output voltages are programmable up to 3.6V.

The LTM4710-1 employs Silent Switcher 2 architecture with internal hot loop bypass capacitors to achieve both low electromagnetic interference (EMI) and high efficiency. The LTM4710-1 is packaged in a compact (6mm × 12mm × 3.54mm) LGA with presolder package and is RoHS compliant.
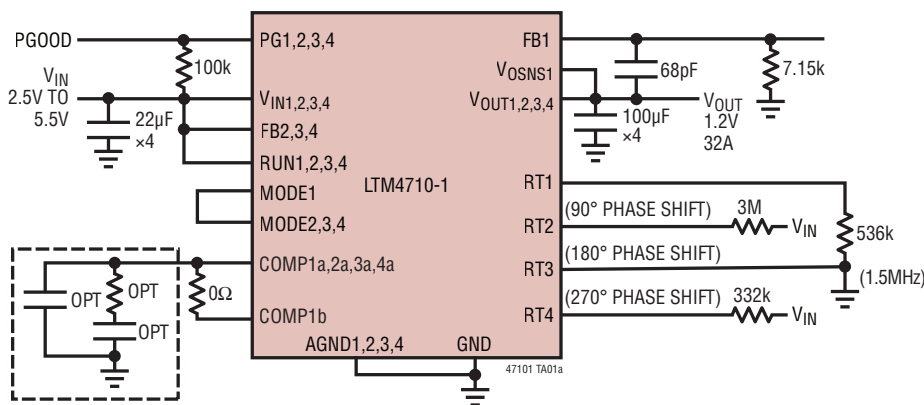
Configurable Output Array

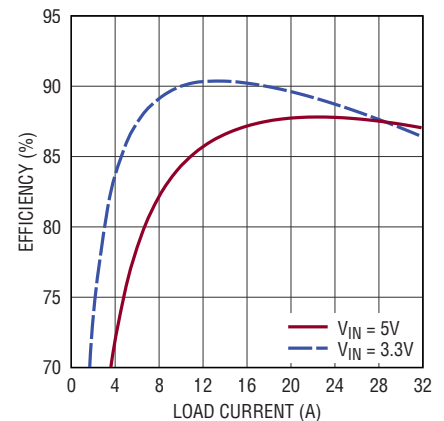All registered trademarks and trademarks are the property of their respective owners.

TYPICAL APPLICATION

Paralleled Single Output, 32A DC/DC µModule Regulator

Efficiency at 1.2V$_{OUT}$

PINS NOT SHOWN IN THIS CIRCUIT: SSTT, SW

Rev. A

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ABSOLUTE MAXIMUM RATINGS   (Note 1)

All Pins Except GND and AGND*n* .... −0.3V to 6V
Operating Junction
Temperature (Note 2) .... −40°C to 125°C

Storage Temperature Range .... −55°C to 125°C
Peak Solder Reflow Body Temperature .... 250°C

PIN CONFIGURATION   (See Pin Functions, Package Pinout Description table)

TOP VIEW

	A	B	C	D	E	F	G	H	J	K	L	M	N	P	R	T	U	V
9	GND	NC	NC	V_{IN1}		BANK6		BANK10 GND	BANK7		BANK11 GND	BANK8			BANK9		BANK12 GND	
8	NC	NC	NC	AGND1														
7	NC	NC	NC	V_{OSNS1}		V_{OUT1}		AGND2	V_{OUT2}		AGND3	V_{OUT3}			V_{OUT4}		AGND4	
6	FB1	COMP1b	COMP1a	RT1		FB2	COMP2b	COMP2a	RT2	FB3	COMP3b	COMP3a	RT3		FB4	COMP4b	COMP4a	RT4
5	RUN1	SSTT1	PG1	MODE1		RUN2	SSTT2	PG2	MODE2	RUN3	SSTT3	PG3	MODE3		RUN4	SSTT4	PG4	MODE4
4		BANK2 V_{IN1}					BANK3 V_{IN2}				BANK4 V_{IN3}					BANK5 V_{IN4}		
3																		
2			BANK1 GND				SW1		SW2		SW3				SW4			
1								GND		GND			GND				GND	

LGA WITH PRESOLDER PACKAGE
162-PIN (6mm × 12mm × 3.54mm)
T_{JMAX} = 125°C, $θ_{JA}$ = 12.2°C/W, $θ_{JCTOP}$ = 6.2°C/W, $θ_{JCBOT}$ = 2.7°C/W
WEIGHT = 0.58g

NOTES:
1. θ VALUES ARE DETERMINED BY SIMULATION PER JESD-51 CONDITIONS.
2. $θ_{JA}$ VALUE IS OBTAINED WITH DEMO BOARD.
3. REFER TO APPLICATIONS INFORMATION SECTION FOR LAB MEASURMENT AND DE-RATING INFORMATION.

ORDER INFORMATION

| PART NUMBER | PAD OR BALL FINISH | PART MARKING | | PACKAGE TYPE | MSL RATING | TEMPERATURE RANGE (SEE NOTE 2) |
		DEVICE	FINISH CODE			
LTM4710EV-1#PBF	SAC305 (RoHS)	4710-1	e1	LGA with Presolder	4	−40°C to 125°C
LTM4710IV-1#PBF	SAC305 (RoHS)	4710-1	e1	LGA with Presolder	4	−40°C to 125°C

- Contact the factory for parts specified with wider operating temperature ranges. Pad or ball finish code is per IPC/JEDEC J-STD-609.

- Recommended LGA and BGA PCB Assembly and Manufacturing Procedures

- LGA and BGA Package and Tray Drawings

Rev. A

ELECTRICAL CHARACTERISTICS
The ● denotes the specifications which apply over specified internal operating junction temperature range (Note 2), otherwise specifications are at $T_A = 25°C$, $V_{IN} = 3.3V$, per the typical application.

SYMBOL	PARAMETER	CONDITIONS		MIN	TYP	MAX	UNITS
V_{IN}	Input DC Voltage		●	2.5		5.5	V
$V_{OUT(RANGE)}$	Output Voltage Range		●	0.5		3.6	V
V_{IN_UVLO}	V_{IN} Undervoltage Lockout	V_{IN} Rising		2.0	2.1	2.2	V
$V_{IN\_UVLO\_HYS}$	V_{IN} Undervoltage Lockout Hysteresis				150		mV
V_{RUN}	RUN Pin On-Threshold	V_{RUN} Rising		0.375	0.4	0.425	V
V_{RUN_HYS}	RUN Pin Hysteresis				75		mV
I_{RUN}	RUN Pin Leakage Current	RUN = 0.4V				±20	nA
$I_{Q(VIN)}$	Input Supply Current	V_{OUT} = 0.5V, MODE = FLOAT, FCM Shutdown, RUN = 0V (Note 5)			50 2		mA μA
$I_{OUT(DC)}$	Output Continuous Current Range	V_{OUT} = 0.5V (Note 3)				8	A
ΔV_{OUT} (LINE)/V_{OUT}	Line Regulation Accuracy	V_{OUT} = 0.5V, V_{IN} = 2.5V to 5.5V, I_{OUT} = 0A				0.2	%/V
ΔV_{OUT} (LOAD)/V_{OUT}	Load Regulation Accuracy	V_{OUT} = 0.5V, I_{OUT} = 0A to 8A	●		0.5	1.5	%
$V_{OUT(AC)}$	Output Ripple Voltage	I_{OUT} = 0A, V_{OUT} = 0.5V			12		mV
I_{SSTT}	Track Pin Soft-Start Pull-Up Current	V_{SSTT} = 0.5V		7	10	13	μA
V_{FB}	Voltage at V_{FB} Pin		●	0.495	0.50	0.505	V
I_{FB}	Current at V_{FB} Pin	(Note 4)				±20	nA
$t_{ON(MIN)}$	Minimum On-Time				40		ns
V_{PG}	Power Good Rising Threshold Power Good Overvoltage Threshold	V_{FB} as a Percentage of Regulated V_{OUT} V_{FB} as a Percentage of Regulated V_{OUT}			98 110		% %
I_{PG}	Power Good Leakage	V_{PG} = 5.5V				50	nA
f_{OSC}	Oscillator Frequency Range			1		5	MHz
SYNC_RANGE	Synchronization Frequency Range	R_T = V_{IN}		1.2		2.6	MHz
SYNC_LEVEL Input	Clock Level High Clock Level Low	R_T = V_{IN}		1.2		0.4	V V

Note 1: Stresses beyond those listed under Absolute Maximum Ratings may cause permanent damage to the device. Exposure to any Absolute Maximum Rating condition for extended periods may affect device reliability and lifetime.

Note 2: The LTM4710-1 is tested under pulsed load conditions such that $T_J \approx T_A$. The LTM4710E-1 is guaranteed to meet performance specifications over the 0°C to 125°C internal operating temperature range. Specifications over the full –40°C to 125°C internal operating temperature range are assured by design, characterization and correlation with statistical process controls. The LTM4710I-1 is guaranteed to meet

specifications over the full –40°C to 125°C internal operating temperature range. Note that the maximum ambient temperature consistent with these specifications is determined by specific operating conditions in conjunction with board layout, the rated package thermal resistance and other environmental factors.
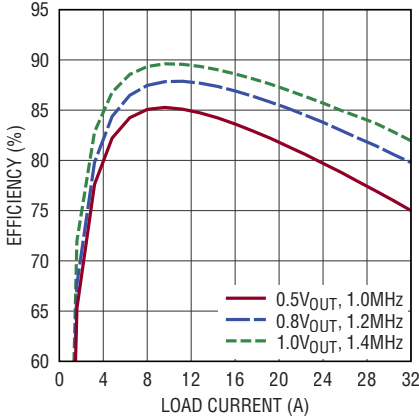
Note 3: See output current thermal derating curves for different V_{IN}, V_{OUT} and T_A.

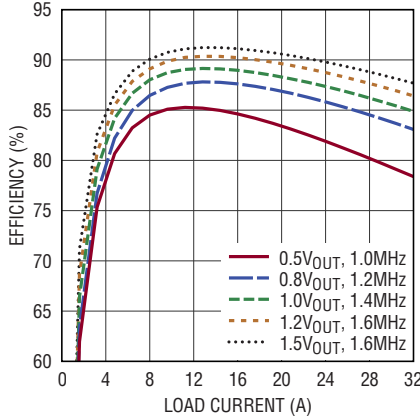**Note 4:** Wafer sort tested.

Note 5: Guaranteed by design.

TYPICAL PERFORMANCE CHARACTERISTICS $T_A = 25°C$, unless otherwise noted.
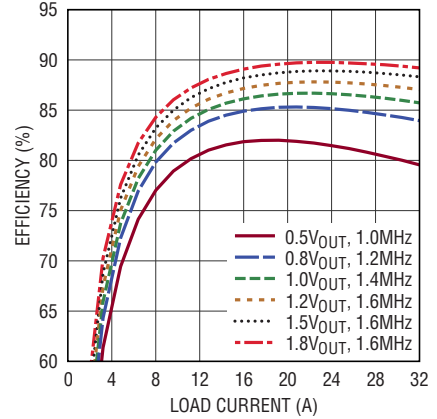
Efficiency, 4-Channel Paralleled
V_{IN} = 2.5V

47101 G01
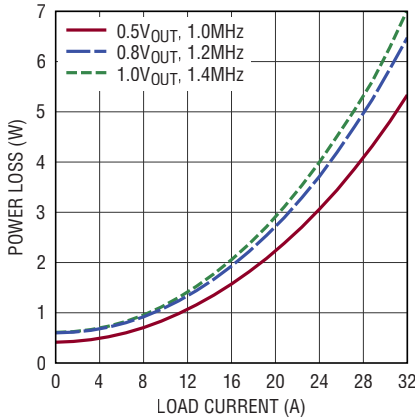
Efficiency, 4-Channel Paralleled
V_{IN} = 3.3V

47101 G02

Efficiency, 4-Channel Paralleled
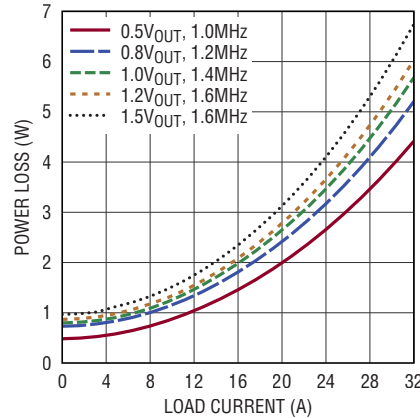**V_{IN} = 5.5V**

47101 G03
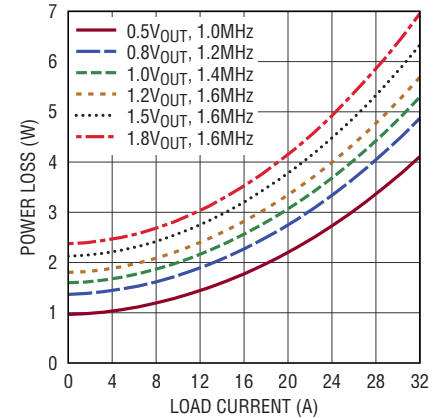
Power Loss, 4-Channel Paralleled
V_{IN} = 2.5V

47101 G04
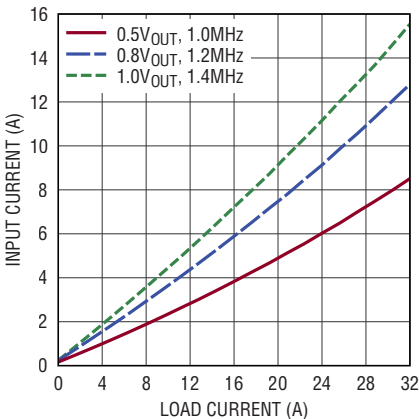
Power Loss, 4-Channel Paralleled
V_{IN} = 3.3V

47101 G05

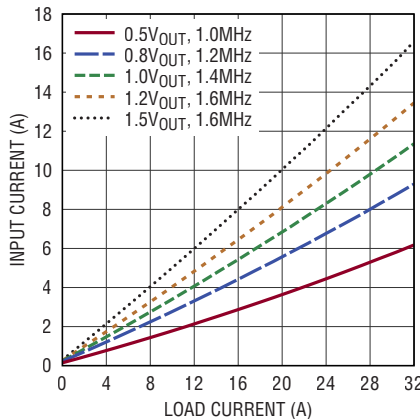**Power Loss, 4-Channel Paralleled**
V_{IN} = 5.5V

47101 G06

Input vs Load Current
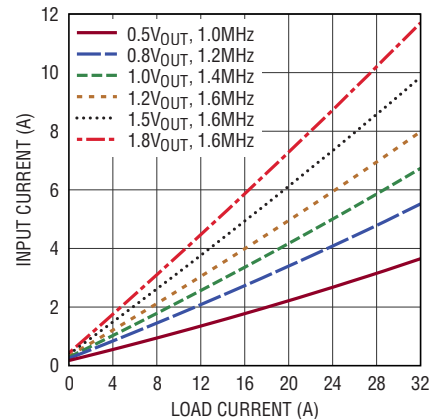**V_{IN} = 2.5V, 4-Channel Paralleled**

47101 G07

Input vs Load Current
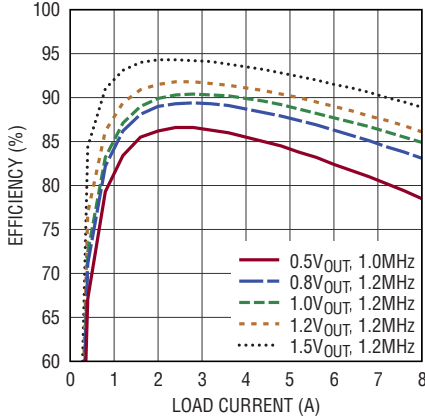**V_{IN} = 3.3V, 4-Channel Paralleled**

47101 G08

Input vs Load Current
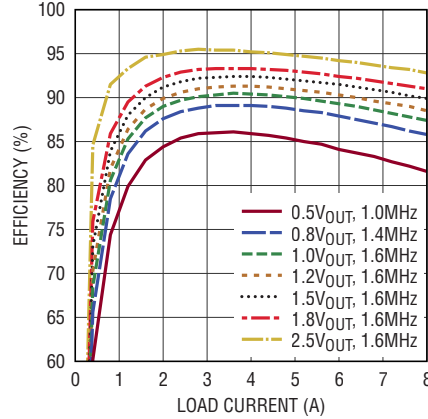**V_{IN} = 5.5V, 4-Channel Paralleled**

47101 G09

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TYPICAL PERFORMANCE CHARACTERISTICS T_A = 25°C, unless otherwise noted.

Efficiency, Single Channel
V_{IN} = 2.5V

EFFICIENCY (%) vs LOAD CURRENT (A)

- 0.5V_{OUT}, 1.0MHz
- 0.8V_{OUT}, 1.2MHz
- 1.0V_{OUT}, 1.2MHz
- 1.2V_{OUT}, 1.2MHz
- 1.5V_{OUT}, 1.2MHz

47101 G10

Efficiency, Single Channel
V_{IN} = 3.3V

EFFICIENCY (%) vs LOAD CURRENT (A)

- 0.5V_{OUT}, 1.0MHz
- 0.8V_{OUT}, 1.4MHz
- 1.0V_{OUT}, 1.6MHz
- 1.2V_{OUT}, 1.6MHz
- 1.5V_{OUT}, 1.6MHz
- 1.8V_{OUT}, 1.6MHz
- 2.5V_{OUT}, 1.6MHz

47101 G11

Efficiency, Single Channel
V_{IN} = 5.5V

EFFICIENCY (%) vs LOAD CURRENT (A)

- 0.5V_{OUT}, 1.0MHz
- 0.8V_{OUT}, 1.2MHz
- 1.0V_{OUT}, 1.4MHz
- 1.2V_{OUT}, 1.4MHz
- 1.5V_{OUT}, 1.6MHz
- 1.8V_{OUT}, 1.6MHz
- 2.5V_{OUT}, 1.8MHz
- 3.3V_{OUT}, 2.2MHz
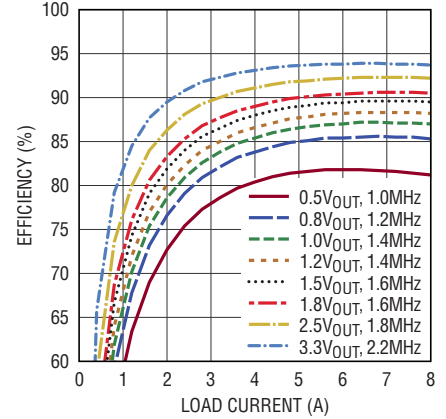
47101 G12

Power Loss, Single Channel
V_{IN} = 2.5V

POWER LOSS (W) vs LOAD CURRENT (A)

- 0.5V_{OUT}, 1.0MHz
- 0.8V_{OUT}, 1.2MHz
- 1.0V_{OUT}, 1.2MHz
- 1.2V_{OUT}, 1.2MHz
- 1.5V_{OUT}, 1.2MHz
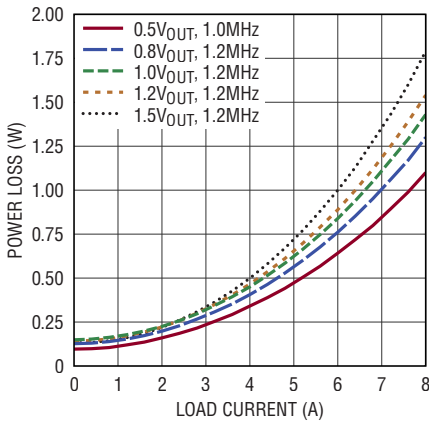
47101 G13

Power Loss, Single Channel
V_{IN} = 3.3V

POWER LOSS (W) vs LOAD CURRENT (A)

- 0.5V_{OUT}, 1.0MHz
- 0.8V_{OUT}, 1.4MHz
- 1.0V_{OUT}, 1.6MHz
- 1.2V_{OUT}, 1.6MHz
- 1.5V_{OUT}, 1.6MHz
- 1.8V_{OUT}, 1.6MHz
- 2.5V_{OUT}, 1.6MHz
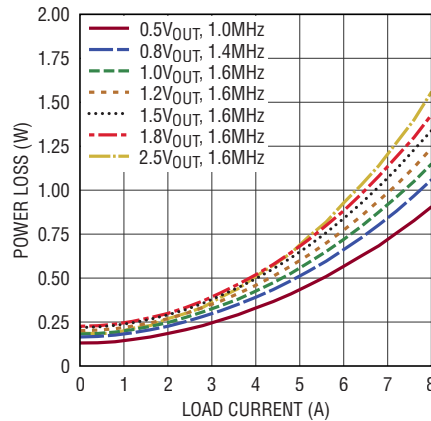
47101 G14

Power Loss, Single Channel
V_{IN} = 5.5V

POWER LOSS (W) vs LOAD CURRENT (A)

- 0.5V_{OUT}, 1.0MHz
- 0.8V_{OUT}, 1.2MHz
- 1.0V_{OUT}, 1.4MHz
- 1.2V_{OUT}, 1.4MHz
- 1.5V_{OUT}, 1.6MHz
- 1.8V_{OUT}, 1.6MHz
- 2.5V_{OUT}, 1.8MHz
- 3.3V_{OUT}, 2.2MHz
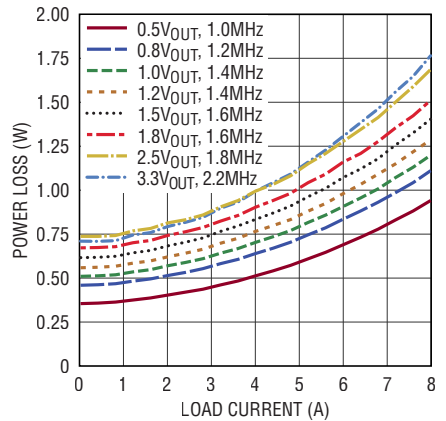
47101 G15

Input vs Load Current
V_{IN} = 2.5V, Single Channel

INPUT CURRENT (A) vs LOAD CURRENT (A)

- 0.5V_{OUT}, 1.0MHz
- 0.8V_{OUT}, 1.2MHz
- 1.0V_{OUT}, 1.2MHz
- 1.2V_{OUT}, 1.2MHz
- 1.5V_{OUT}, 1.2MHz
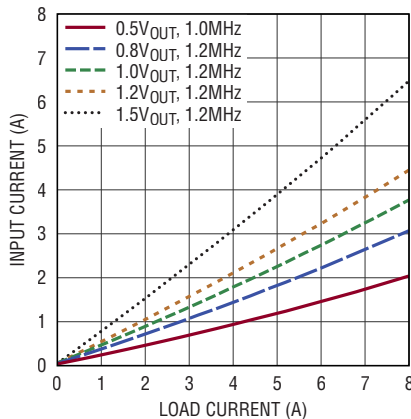
47101 G16

Input vs Load Current
V_{IN} = 3.3V, Single Channel

INPUT CURRENT (A) vs LOAD CURRENT (A)

- 0.5V_{OUT}, 1.0MHz
- 0.8V_{OUT}, 1.4MHz
- 1.0V_{OUT}, 1.6MHz
- 1.2V_{OUT}, 1.6MHz
- 1.5V_{OUT}, 1.6MHz
- 1.8V_{OUT}, 1.6MHz
- 2.5V_{OUT}, 1.6MHz
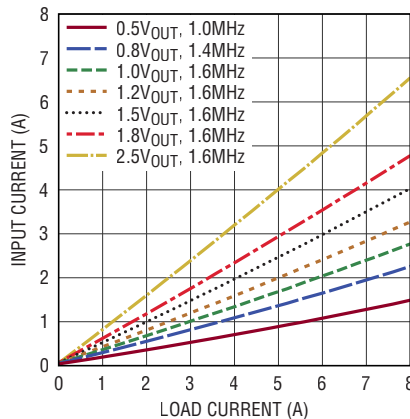
47101 G17

Input vs Load Current
V_{IN} = 5.5V, Single Channel

INPUT CURRENT (A) vs LOAD CURRENT (A)

- 0.5V_{OUT}, 1.0MHz
- 0.8V_{OUT}, 1.2MHz
- 1.0V_{OUT}, 1.4MHz
- 1.2V_{OUT}, 1.4MHz
- 1.5V_{OUT}, 1.6MHz
- 1.8V_{OUT}, 1.6MHz
- 2.5V_{OUT}, 1.8MHz
- 3.3V_{OUT}, 2.2MHz

47101 G18

Rev. A
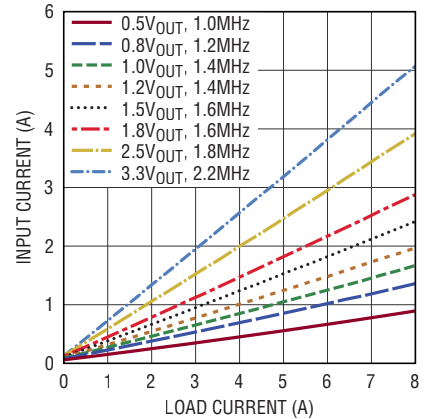
TYPICAL PERFORMANCE CHARACTERISTICS T_A = 25°C, unless otherwise noted.

Steady State V_{SW} with Persistence On

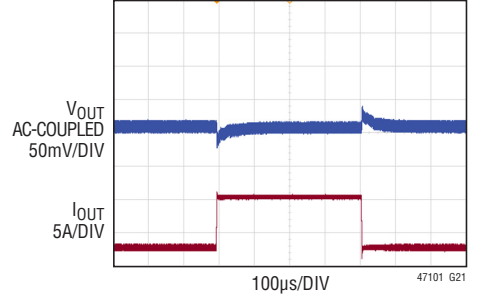V_{SW1} 2V/DIV
V_{SW2} 2V/DIV
V_{SW3} 2V/DIV
V_{SW4} 2V/DIV

200ns/DIV   47101 G19
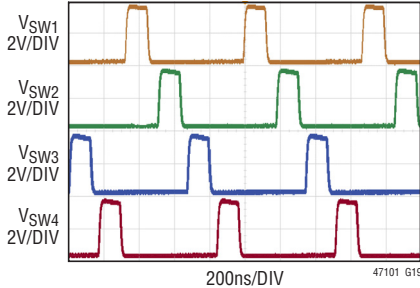
V_{IN} = 3.3V, V_{OUT} = 0.6V, I_{OUT} = 30A, f_{SW} = 1.5MHz, C_{OUT} = 100µF × 4

Steady State Voltage Ripple

V_{OUT} AC-COUPLED 10mV/DIV

1µs/DIV   47101 G20
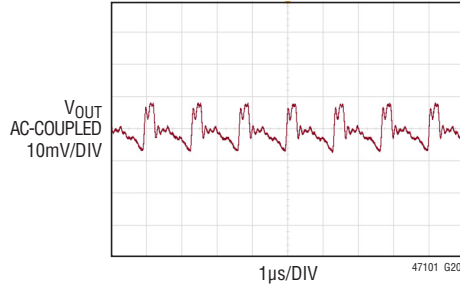
V_{IN} = 3.3V, V_{OUT} = 0.6V, I_{OUT} = 30A, f_{SW} = 1.5MHz, C_{OUT} = 100µF × 4

Load Transient Response

V_{OUT} AC-COUPLED 50mV/DIV

I_{OUT} 5A/DIV

100µs/DIV   47101 G21

V_{IN} = 3.3V, V_{OUT} = 0.6V, f_{SW} = 1.5MHz, C_{OUT} = 100µF × 4, C_{FF} = 20pF, 0A ~ 7.5A (25%) LOAD STEP, 4-PHASE

Start-Up

V_{RUN} 2V/DIV
V_{PG} 2V/DIV
V_{OUT} 500mV/DIV
V_{SSTT} 1V/DIV

10ms/DIV   47101 G22
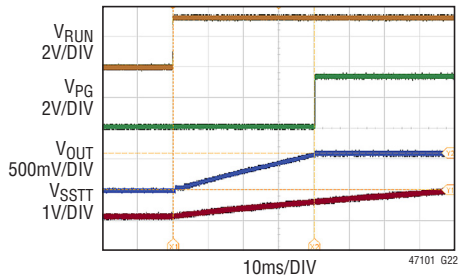
V_{IN} = 3.3V, V_{OUT} = 0.6V, f_{SW} = 1.5MHz, C_{OUT} = 100µF × 4

Load Regulation, 1V DC3164A-B Demo Board

4-CHANNEL PARALLELED
V_{IN} = 3.3V
V_{OUT} = 1V
f_{SW} = 1.4MHz

LOAD REGULATION (%) vs LOAD CURRENT (A)

47101 G23
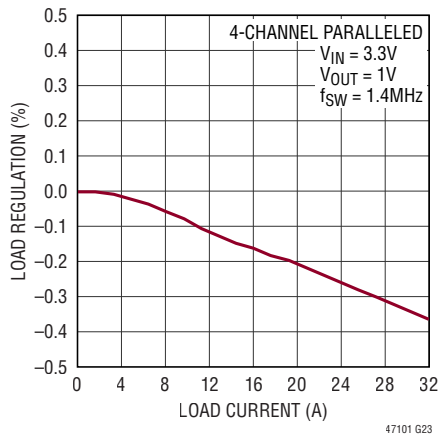
Radiated Emissions 8A Load on Each Channel DC3164A-B, without Ferrite Bead

CISPR32 CLASS B 10m

EMISSION LEVEL (dBµV/m) vs FREQUENCY (MHz)

V_{IN} = 3.3V
V_{OUT1} = 0.8V, V_{OUT2} = 1V, V_{OUT3} = 1.2V, V_{OUT4} = 1.5V

47101 G24
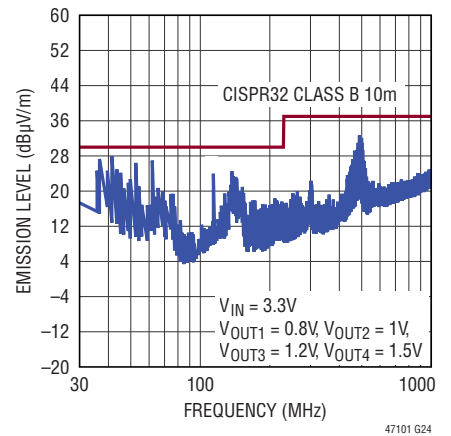
PIN FUNCTIONS

⚠ **PACKAGE ROW AND COLUMN LABELING MAY VARY AMONG μModule PRODUCTS. REVIEW EACH PACKAGE LAYOUT CAREFULLY.**

GND (Bank 1, Banks 10 – 12, Pin A9): Power Ground Pins for All Input and Output Returns.

V_{IN1}, V_{IN2}, V_{IN3}, V_{IN4} (Banks 2 – 5, Pin D9): Power Input Pins. Apply input voltage between these pins and GND pins. Recommend placing input decoupling capacitance directly between V_{IN} pins and GND pins.

V_{OUT1}, V_{OUT2}, V_{OUT3}, V_{OUT4} (Banks 6 – 9): Power Output Pins of Each Switching Mode Regulator. Apply output load between these pins and GND pins. Recommend placing output decoupling capacitance directly between these pins and GND pins.

RUN1, RUN2, RUN3, RUN4 (Pins A5, F5, K5, R5): Enables chip operation by connecting RUN above 0.4V. Connecting it to GND shuts down the device.

FB1, FB2, FB3, FB4 (Pins A6, F6, K6, R6): The negative input of the error amplifier for the switching mode regulator channel. The LTM4710-1 regulates the voltage between FB and AGND to 500mV. For FB1, this pin is internally connected to V_{OSNS1} with a 10k 0.5% precision resistor. Different output voltages can be programmed with an additional resistor between V_{OSNS1} and AGND. For FB2, FB3 and FB4, a resistor divider connecting to V_{OUT} sets the output voltage. In PolyPhase® operation, tie the FB pins to V_{IN} to disable the internal error amplifier. See the Applications Information section for details.

SSTT1, SSTT2, SSTT3, SSTT4 (Pins B5, G5, L5, T5): Soft-Start, Tracking and Temperature Monitor Pins. An internal 10μA current into an external capacitor on the soft-start pin programs the output voltage ramp rate during start-up. When SSTT is below 0.5V, the V_{FB} pin voltage will track the SSTT pin voltage. When SSTT is above 0.5V, the tracking function is disabled, the internal reference resumes control of the error amplifier and the SSTT pin servos to a voltage representative of a junction temperature. During shutdown and fault conditions, the SSTT pin is pulled to ground.

COMP1b, COMP2b, COMP3b, COMP4b (Pins B6, G6, L6, T6): Internal Compensation Network. These pins are to be connected to their respective COMPa pins. When utilizing specific external compensation, float these pins.

PG1, PG2, PG3, PG4 (Pins C5, H5, M5, U5): Output power good with open-drain logic of the switching mode regulator channel. PG is pulled to ground when the voltage on the FB pin is not within –2% and +10% of the internal 0.5V reference.

COMP1a, COMP2a, COMP3a, COMP4a (Pins C6, H6, M6, U6): Current control threshold and error amplifier compensation point of the switching mode regulator channel.

MODE1, MODE2, MODE3, MODE4 (Pins D5, J5, N5, V5): MODE pin facilitates multiphase operation and synchronization to an external clock. Depending on the mode of operation, the MODE either accepts a clock pulse or outputs a clock pulse at its operating frequency. See the Applications Information section for details.

RT1, RT2, RT3, RT4 (Pins D6, J6, N6, V6): The frequency pin sets the oscillator frequency with an external resistor to AGND or sets the phasing for multiphase operation. See the Applications Information of section for frequency adjustment.

V_{OSNS1} (Pin D7): Output Voltage Sense Pin of Channel 1. Internally, this pin is connected to the FB1 pin with a 10k, 0.5% precision resistor. It is very important to connect this pin to the V_{OUT1} since this is the feedback path and cannot be left open. See the Applications Information section for details.

AGND1, AGND2, AGND3, AGND4 (Pins D8, H7, L7, U7): The AGND pin is the output voltage remote ground sense. Connect the AGND pin directly to the negative terminal of the output capacitor at the load and to the feedback divider resistor.

SW1, SW2, SW3, SW4 (Pins G2, K2, N2, T2): Switching node waveform monitoring.

NC (Pins A7, A8, B7, B8, B9, C7, C8, C9): No Connection. Leave these pins open.

BLOCK DIAGRAM

47101 BD
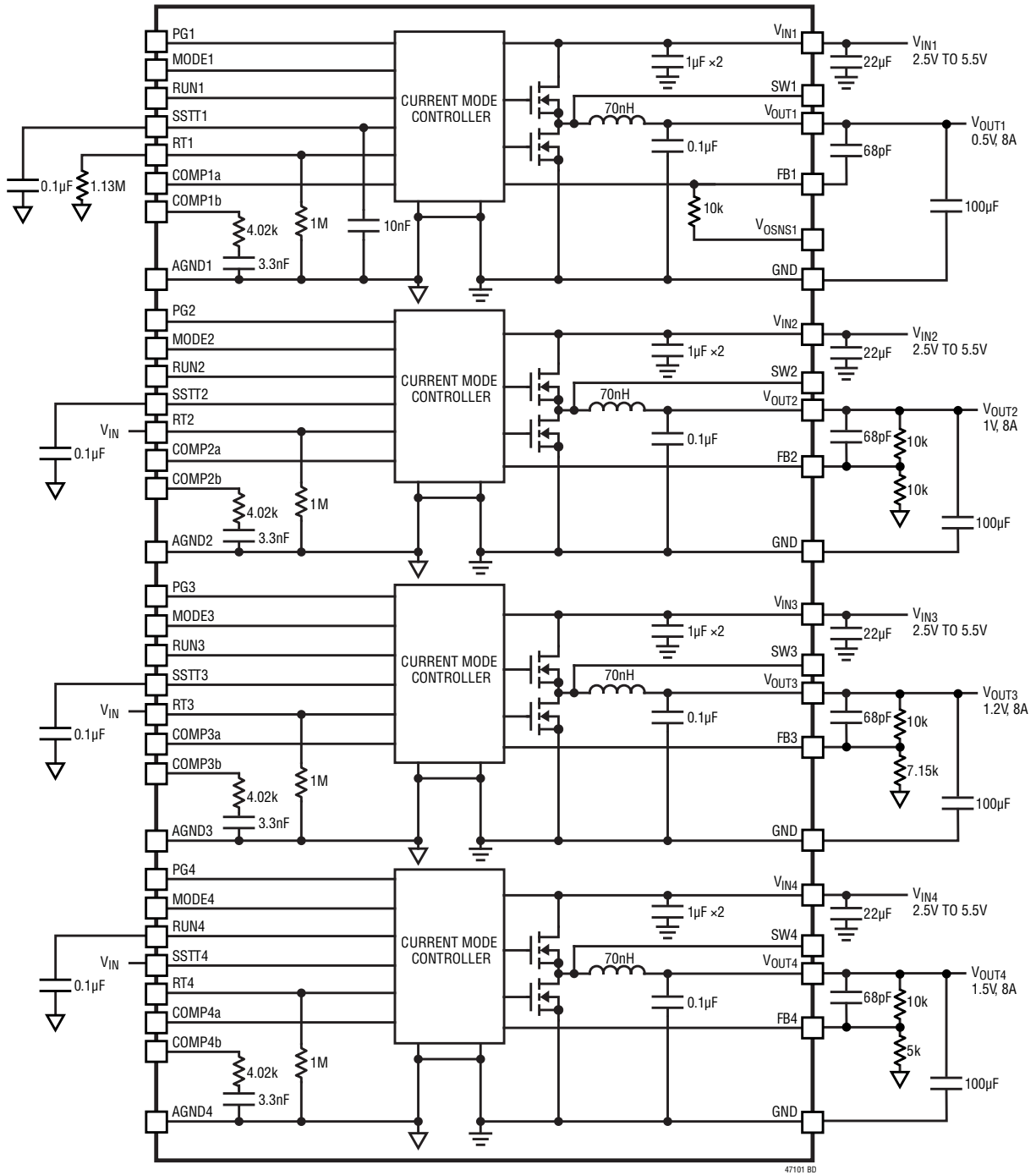
DECOUPLING REQUIREMENTS (Per Channel)

SYMBOL	PARAMETER	CONDITIONS	MIN	TYP	MAX	UNITS
C_{IN}	External Input Capacitor Requirement (V_{IN} = 2.5V to 5.5V, V_{OUT} = 0.5V)	I_{OUT} = 8A	22			µF
C_{OUT}	External Output Capacitor Requirement (V_{IN} = 2.5V to 5.5V, V_{OUT} = 0.5V)	I_{OUT} = 8A	100			µF

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OPERATION

The LTM4710-1 is a quad output step-down switch mode DC/DC power supply. It integrates four separate regulators, each capable of delivering up to 8A continuous output current with few external input and output capacitors. Each regulator provides precisely regulated output voltage programmable from 0.5V to 3.6V over a 2.5V to 5.5V input voltage range. See typical application schematic (Figure 1).

The LTM4710-1 integrates four separate constant-frequency peak current mode control regulators, power MOSFETs, inductors, and other supporting discrete components. It employs Silent Switcher 2 technology, which allows fast switching edges for high efficiency at high switching frequencies, while simultaneously achieving good EMI performance. Ceramic Capacitors on V_{IN} keep all the fast AC current loops small, improving EMI performance.

With current mode control and internal feedback loop compensation, the LTM4710-1 has sufficient stability margins and fast transient performance with a wide range of output capacitors, even with all ceramic output capacitors.

The switching frequency for LTM4710-1 can be adjusted by an external resistor from RT to AGND, or the LTM4710-1 can be externally synchronized to a clock. See the Applications Information section.

Current mode control provides cycle-by-cycle fast current limiting. Peak current limiting is provided in an overcurrent condition. The internal overvoltage and undervoltage comparators pull the open-drain PG output low if the output feedback voltage exits a –2% and +10% window around the regulation point. Furthermore, in an overvoltage condition, the internal top MOSFET is turned off, and the bottom MOSFET is turned on and held on until the overvoltage condition clears.

The multiphase operation can be easily configurable with synchronization and phase mode controls.

Pulling the RUN pin to GND forces the controller into its shutdown state, turning off both power MOSFETs and most of the internal control circuitry.

The SSTT pin is used for power supply tracking, soft-start programming and, and monitoring die temperature. See the Applications Information section.

Forced continuous mode (FCM) is the only operation mode recommended for low ripple and low noise consideration. The switching frequency of the four channels should always be synchronized regardless the output(s) are paralleled or independent. For multiphase paralleled output, phase-shift interleaving is recommended. For independent outputs, an aligned main-switch turn-on transition is recommended. See the Applications Information section and Typical Applications for more information.

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The typical LTM4710-1 application circuit is shown in Figure 1. External component selection is primarily determined by the input voltage, the output voltage and the maximum load current. See Table 10 for specific external capacitor requirements for a particular application.

V_{IN} to V_{OUT} Step-Down Ratios

There are restrictions in the minimum V_{OUT} step-down ratio that can be achieved for a given input voltage due to the minimum on-time limits of the regulator.

The minimum on-time limit imposes a minimum duty cycle of the converter, which can be calculated with Equation 1.

$$D_{(MIN)} = t_{ON(MIN)} \bullet f_{SW} \tag{1}$$

where $t_{ON(MIN)}$ is the minimum on-time, 40ns typical for LTM4710-1. In the rare cases where the minimum duty cycle is surpassed, the output voltage will remain in regulation, but the switching frequency will decrease from its programmed value.

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Output Voltage Programming

The PWM controller has an internal 0.5V reference voltage. As shown in the Block Diagram, a 10k (0.5% tolerance) internal feedback resistor is included in channel 1 only. The 10k resistor connects FB1 to V_{OSNS1}, which should be directly connected to the V_{OUT1} sense point. 10k external top feedback resistor is recommended for $V_{OUT2,3,4}$ if operating independently. Adding a resistor R_{BOT} from FB pin to the AGND pin programs the output voltage (Equation 2).

$$V_{OUT}(V) = 0.5V \bullet \frac{10k + R_{BOT}}{R_{BOT}} \qquad (2)$$

Input Decoupling Capacitors

Each channel of the LTM4710-1 module should be connected to a low AC-impedance DC source. For the regulator, at least 22µF input ceramic capacitor is recommended for RMS ripple current decoupling. Bulk input capacitors are needed when the input source impedance is compromised by long inductive leads, traces or not enough source capacitance. The bulk capacitor can be an electrolytic aluminum capacitor or polymer capacitor.

Without considering the inductor current ripple, the RMS current of the input capacitor can be estimated with Equation 3.

$$I_{CIN(RMS)} = \frac{I_{OUT(MAX)}}{\eta\%} \bullet \sqrt{D \bullet (1-D)} \qquad (3)$$

where η is the estimated efficiency of the power module.

Output Decoupling Capacitors

With an optimized high frequency, high bandwidth design, only a 100µF low ESR output ceramic capacitor is required for each channel to achieve low output voltage ripple and a very good transient response. Additional output filtering may be required by the system designer, if further reduction of output ripples or dynamic transient spikes is required. Table 10 shows a matrix of different output voltages and output capacitors to minimize the voltage droop and overshoot during a 2A (25%) load step transient.

The multiphase operation will reduce effective output ripple as a function of the number of phases. Application Note 77

discusses this noise reduction versus output ripple current cancellation, but the output capacitance will be more a function of stability and transient response. The LTpowerCAD® design tool is available to download on-line for output ripple, stability and transient response analysis and calculating the output ripple reduction as the number of phases implemented increases by N times.

Mode of Operation

The MODE pin is either a clock input or a clock output. When configured as clock input, it synchronizes the switching frequency to an external clock (see Table 1).

The LTM4710-1 should operate in forced continuous mode (FCM) for low-noise applications.

Table 1. LTM4710-1 Single Phase Configuration

RT PIN CONNECTION	MODE PIN CONNECTION	MODE OF OPERATION	SWITCHING FREQUENCY
V_{IN}	Clock Input	Forced Continuous	External Clock
Float/Resistor to AGND	Clock Output	Forced Continuous	R_T Programmed

Setting the Operating Frequency

The frequency can be programmed by tying a resistor from RT to AGND pins (Equation 4).

$$R_T = 1113 \bullet f_{(SW)}^{-1.64} \qquad (4)$$

where R_T is in kΩ and f_{SW} is the desired switching frequency in MHz.

The frequency can be programmed to switch from 1MHz to 5MHz. Table 2 shows the necessary R_T value for a desired switching frequency.

Table 2. SW Frequency vs R_{FREQ} Value

f_{SW} (MHz)	R_T (kΩ)
1	1130
1.5	536
2	340
2.2	301
3	196
4	140
5	105

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Frequency Synchronization and Clock Input

The LTM4710-1 switching frequency can be adjusted by synchronizing the internal PLL circuit to an external square wave clock applied at the MODE pin. The synchronization frequency range is 1.2MHz to 2.6MHz. The external clock amplitude must be greater than 1.2V and less than 0.4V.

The internal PLL starts up at the 2MHz default frequency. After detecting an external clock on the first rising edge of the MODE pin, the internal PLL gradually adjusts its operating frequency to match the frequency and phase of the MODE signal.

Multiphase Operation

For output loads that demand more than 8A of current, multiple LTM4710-1 channels can be paralleled to run out of phase to provide more output current without increasing input and output voltage ripples. Table 3 shows the configuration for multiphase operation.

Table 3. LTM4710-1 Multiphase Configuration

PHASE	RT PIN	FB PIN	MODE PIN	SWITCHING FREQUENCY
Main	V_{IN}	V_{OUT} Divider	Clock Input	External Clock
Main	Resistor to AGND	V_{OUT} Divider	Clock Output	R_T Programmed
Subordinary	V_{IN} Divider	V_{IN}	Clock Input	External Clock

To parallel multiple LTM4710-1 channels to achieve the same switching frequency, perfect interleaved phase shift and accurate current sharing between different channels, one of the LTM4710-1 channels will become the main channel, and the rest of the LTM4710-1 channels need to be programmed as the subordinary channels.

Connecting the RT pin of the main phase to a resistor to AGND programs the frequency and configures the MODE pin to become the clock output used to drive the MODE pin of the subordinary phase(s).

Connecting the RT pin of the main phase to V_{IN} configures the MODE pin to become an input capable of accepting an external clock.

Connecting the V_{FB} pin to V_{IN} configures a phase as a subordinary phase. The MODE becomes a clock input, and the voltage control loop is disabled. The subordinary phase current control loop is still active, and the peak current is controlled via the shared COMP node.

The phasing of a subordinary phase relative to the main phase is programmed with a resistor divider on the RT pin. The use of 1% resistors is recommended. See Table 4 for more information. Figure 17 shows an example.

Table 4. Subordinary Phase Shift Related to MODE Input

PHASE ANGLE BETWEEN SUBORDINARY MODULE AND MODE INPUT (°)	R_T RESISTOR TO V_{IN} (Ω)
0	0
90	3M
120	1.4M
180	(R_T = GND)
240	715k
270	332k

Application Note 77 provides a detailed explanation of multiphase operation. The input RMS ripple current cancellation mathematical derivation are presented, and a graph is displayed representing the RMS ripple current reduction as a function of the number of interleaved phases (see Figure 1).
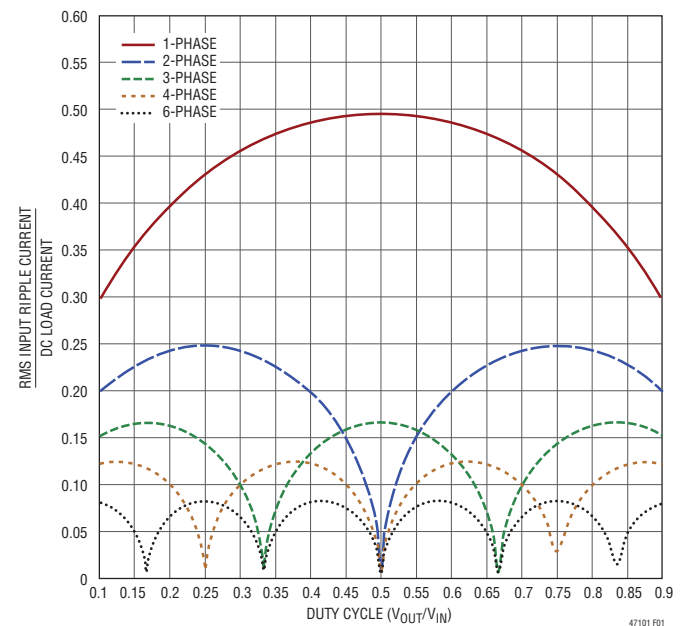

Figure 1. Input RMS Current Ratios to DC Load Current as a Function of Duty Cycle

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The LTM4710-1 device is an inherently current mode-controlled device, so that parallel modules will have very good current sharing. This will balance the thermals on all channels. Connect the RUN, COMP and PG pin of each paralleling channel together and connect FB to V_{IN} for subordinary channels. Figure 17 shows an example of parallel operation and pin connection.

Soft-Start/Output Voltage Tracking/ Temperature Monitoring

The SSTT pin function facilitates supply sequencing, limits V_{IN} inrush current and reduces start-up output overshoot. An internal 10μA charge up a capacitor on the SSTT pin hence program the ramp rate of the output voltage. SSTT pin can also be externally driven by another voltage source. During the soft-start ramp, when the SSTT voltage is below 0.5V, the output voltage will proportionally track the SSTT pin voltage. When the SSTT voltage is above 0.5V, the SSTT pin will servo to a voltage proportional to the LTM4710-1 die junction temperature (see Figure 2). The SSTT capacitor is reset during shutdown, V_{IN} UVLO and over thermal shutdown.
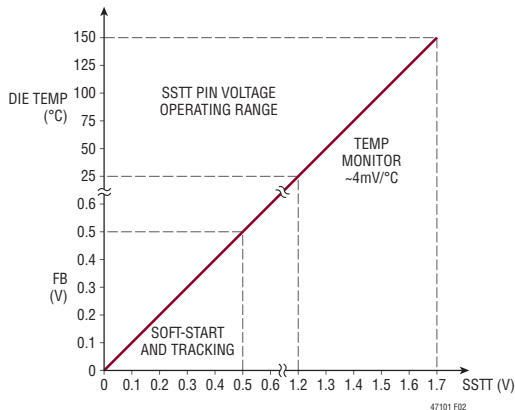

Figure 2. Soft-Start and Temperature Monitor Operation

The total soft-start time can be calculated with Equation 5.

$$t_{SS} = C_{SS} \cdot \frac{500mV}{10\mu A} \tag{5}$$

where C_{SS} is the capacitance on the SSTT pin. FCM is disabled during the soft-start process to prevent the current from reversing.

A default 10nF soft-start cap is connected to SSTT1 inside the module, resulting in a 0.5ms default start-up time on channel 1. The presence of this cap is to simplify customers' design in most cases.

Output Power Good

When the LTM4710-1's output voltage is within the –2% and +10% window of the nominal regulation voltage, the output is considered good, and the open-drain PG pin goes high impedance and is typically pulled high with an external resistor. Otherwise, the internal pull-down device will pull the PG pin low. To prevent glitching both the upper and lower thresholds, include 1% of hysteresis as well as a built-in time delay, typically 100μs. The PG pin is also actively pulled low during fault conditions: RUN pin is low, V_{IN} is too low or in thermal shutdown.

For multiphase applications, the PG pin is used for communication between the main and sub-ordinary phases. Connect the PG pins together and pull-up to V_{IN} or V_{OUT} with an external resistor. PG pins MUST be pulled higher than 490mV.

Stability Compensation

The LTM4710-1 has already been internally optimized and compensated for all output voltages and capacitor combinations including all ceramic capacitor applications when COMPb is tied to COMPa.

Table 10 is provided for most application requirements using the optimized internal compensation. For applications that need to achieve high bandwidth control loop compensation with enough phase margin, a 68pF feed-forward capacitor is recommended from V_{OUT} to V_{FB} pin. For specific optimized requirement, disconnect COMPb from COMPa and apply a Type II C-R-C compensation network from COMPa to AGND to achieve external compensation. The LTpowerCAD design tool can be downloaded online to perform specific control loop optimization and analyze the control stability and load transient performance.

RUN Enable

The LTM4710-1 has a precision threshold RUN pin to enable or disable the switching. When forced low, the RUN pin puts the LTM4710-1 into a low current shutdown

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mode. The rising threshold of the RUN comparator is 400mV, with 75mV of hysteresis. It can be tied to V_{IN} if the shutdown feature is not used. Adding a resistor divider from V_{IN} to RUN programs the LTM4710-1 to regulate the output only when V_{IN} is above a desired voltage. Typically, this threshold, $V_{IN(EN)}$, is used in situations where the input supply is current limited or has a relatively high source resistance. A switching regulator draws constant power from the source, so the source current increases as the source voltage drops. This looks like a negative resistance load to the source and can cause the source to current limit or latch low under low source voltage conditions. The $V_{IN(EN)}$ threshold prevents the regulator from operating at source voltages where problems may occur. This threshold can be adjusted by setting the values R1 and R2 such that they satisfy Equation 6.

$$V_{IN(EN)} = \left(\frac{R1}{R2} + 1 \right) \bullet 400mV \qquad (6)$$

where the LTM4710-1 will remain off until V_{IN} is above $V_{IN(EN)}$. Due to the comparator's hysteresis, switching will not stop until the input falls slightly below $V_{IN(EN)}$.

Alternatively, a resistor divider from an output of another channel to the RUN pin of the LTM4710-1 provides event-based power-up sequencing, enabling the LTM4710-1 when the output of the other regulator reaches a predetermined level.

Thermal Considerations and Output Current Derating

The thermal resistances reported in the Pin Configuration section of this data sheet are consistent with those parameters defined by JESD51-12 and are intended for use with finite element analysis (FEA) software modeling tools that leverage the outcome of thermal modeling, simulation, and correlation to hardware evaluation performed on a µModule package mounted to a hardware test board. The motivation for providing these thermal coefficients in found in JESD51-12 ("Guidelines for Reporting and Using Electronic Package Thermal Information").

Many designers may use laboratory equipment and a test vehicle, such as the demo board, to anticipate the µModule regulator's thermal performance in their application at various electrical and environmental operating

conditions to compliment any FEA activities. Without FEA software, the thermal resistances reported in the Pin Configuration section are, in-and-of themselves, not relevant to providing guidance on thermal performance; instead, the derating curves provided in the data sheet can be used in a manner that yields insight and guidance pertaining to one's application-usage and can be adapted to correlate thermal performance to one's own application.

The Pin Configuration section typically gives three thermal coefficients explicitly defined in JESD 51-12; these coefficients are quoted or paraphrased below.

1. θ_{JA}, the thermal resistance from junction to ambient, is the natural convection junction-to-ambient air thermal resistance measured in a one cubic foot sealed enclosure. This environment is sometimes referred to as "still air", although natural convection causes the air to move. This value is determined with the part mounted to the demo board DC3164A-B.

2. $\theta_{JCbottom}$, the thermal resistance from junction to bottom of the product case, is determined with all the component power dissipation flowing through the bottom of the package. In the typical module regulator, the bulk of the heat flows out the bottom of the package, but there is always heat flow out into the ambient environment. As a result, this thermal resistance value maybe useful for comparing packages, but the test conditions don't generally match the user's application.

3. θ_{JCtop}, the thermal resistance from the junction to the top of the product case, is determined with nearly all of the component power dissipation flowing through the top of the package. As the electrical connections of the typical µModule are on the bottom of the package, it is rare for an application to operate such that most of the heat flows from the junction to the top of the part. As in the case of $\theta_{JCbottom}$, this value may be useful for comparing packages, but the test conditions don't generally match the user's application.

A graphical representation of the aforementioned thermal resistances is shown in Figure 3; blue resistances are contained within the µModule regulator, whereas green resistances are external to the µModule.
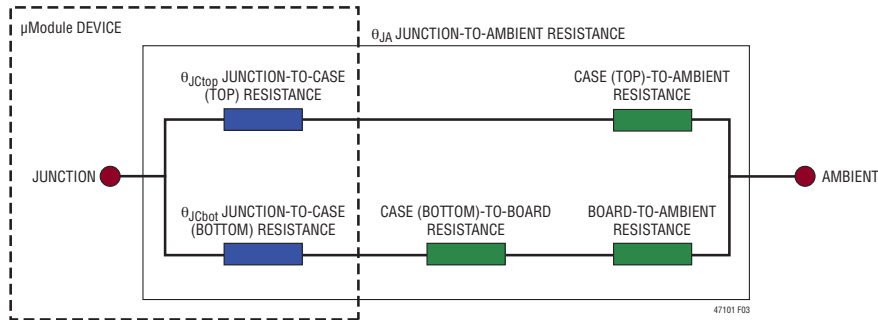
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Figure 3. Graphical Representation of JESD51-12 Thermal Coefficients

Within the LTM4710-1 module, be aware that there are multiple power devices and components dissipating power, with the consequence that the thermal resistances relative to different junctions of components or die are not exactly linear to total package power loss. To reconcile this complication without sacrificing modeling simplicity—but also, not ignoring practical realities—an approach has been taken using FEA software modeling along with laboratory testing in a controlled-environment chamber to reasonably define and correlate the thermal resistance values supplied in this data sheet: (1) Initially, FEA software is used to accurately build the mechanical geometry of the µModule and the specified PCB with all of the correct material coefficients along with accurate power loss source definitions; (2) this model simulates a software-defined JEDEC environment consistent with JSED51-12 to predict power loss heat flow and temperature readings at different interfaces that enable the calculation of the JEDEC-defined thermal resistance values; (3) the model and FEA software is used to evaluate the LTM4710-1 with heat sink and airflow; (4) having solved for and analyzed these thermal resistance values and simulated various operating conditions in the software model, a thorough laboratory evaluation replicates the simulated conditions with thermocouples within a controlled-environment chamber while operating the device at the same power loss as that which was simulated. An outcome of this process and due diligence yields a set of derating curves, as shown in this datasheet.

After these laboratory tests have been performed and correlated to the LTM4710-1 model, then the θ_{JB} and θ_{BA} are summed together to provide a value that should closely equal the θ_{JA} value because approximately 100% of the power loss flows from the junction through the board into ambient with no airflow or top mounted heat sink.

Figure 5 and Figure 6 (3.3V and 5V) power loss curves can be used in coordination with Figure 7 through Figure 15 load current derating curves for calculating an approximate θ_{JA} thermal resistance for the LTM4710-1 with various heat sinking and airflow conditions. The power loss curves are taken at room temperature and are increased with multiplicative factors according to the junction temperature. This approximate factor is 1.2 for 120°C at junction temperature. The maximum load current is achievable while increasing ambient temperature as long as the junction temperature is less than 120°C, which is 5°C guard band from The maximum junction temperature of 125°C. When the ambient temperature reaches a point where the junction temperature is 120°C, then the load current is lowered to maintain the junction at 120°C while increasing the ambient temperature up to 120°C. The derating curves are plotted with the output current starting at 36A and the ambient temperature at 30°C. The output voltages are 0.5V, 0.8V, 1V, 1.2V, and 1.5V. Thermal models are derived from several temperature measurements in a controlled temperature chamber along with thermal modeling analysis. The junction temperatures are monitored while ambient temperature is increased with and without airflow. The power loss increase with ambient temperature change is factored into the derating curves. The junctions are maintained at 120°C maximum while lowering output current or power

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with increasing the ambient temperature. The decreased output current will decrease the internal module loss as ambient temperature is increased. The monitored junction temperature of 120°C minus the ambient operating temperature specifies how much module temperature rise can be allowed. As an example, in Figure 13, the load current is derated to be 19.2A at 86.4°C with no air or heat sink, and the total power loss for $3.3V_{IN}$ to $1.2V_{OUT}$ at 19.2A is 2.6W (Figure 5), then multiply by the 1.2 coefficient for 120°C junction temperature, the total power loss for 4 channels is 3.2W, if 86.4°C ambient temperature is subtracted from 120°C junction temperature, the difference of the 33.6°C divided by 3.2W equals 10.5°C/W. Table 5 specifies an 11°C/W value which is very close. Table 5 to Table 9 provide equivalent thermal resistances for 0.5V, 0.8V, 1V, 1.2V and 1.5V outputs with and without airflow. The derived thermal resistances in Table 5 to Table 9 for the various conditions can be multiplied by the calculated power loss as a function of ambient temperature to derive temperature rise above ambient, thus maximum junction temperature. Room temperature power loss

can be derived from the efficiency curves in the Typical Performance Characteristics section and adjusted with the above ambient temperature multiplicative factors. The printed circuit board is a 1.6mm thick six-layer board with two-ounce copper on all six layers. The PCB dimensions are 4.25-inch × 4.48-inch.
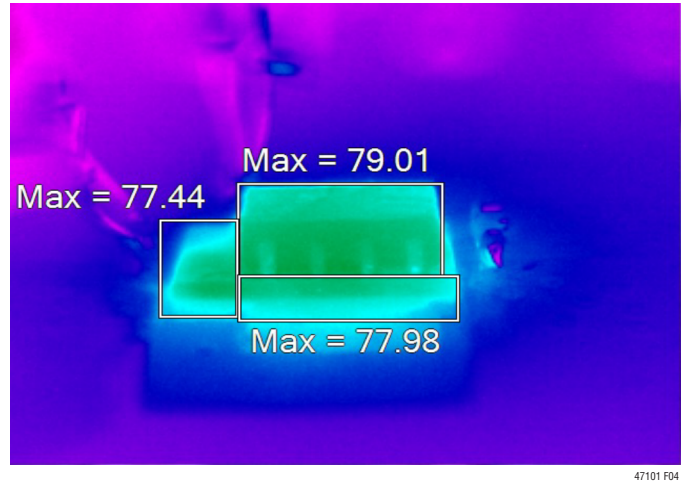

Figure 4. Thermal Image, LTM4710-1 Running from 3.3V Input to 0.5V, Paralleled 32A Output with No Airflow, No Heat Sink
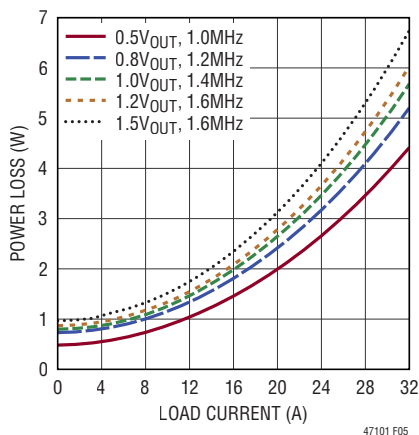

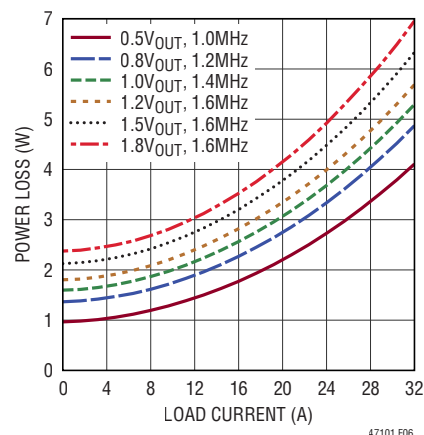**Figure 5. Power Loss, 4-Channel Paralleled V_{IN} = 3.3V**

Figure 6. Power Loss, 4-Channel Paralleled V_{IN} = 5.5V
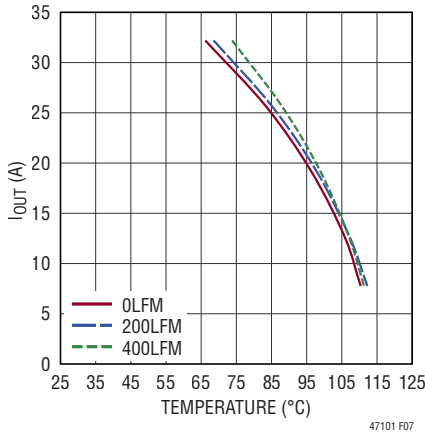
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Figure 7. Derating, 4-Channel Paralleled V_{IN} = 3.3V, V_{OUT} = 0.5V DC3164A-B Demo Board
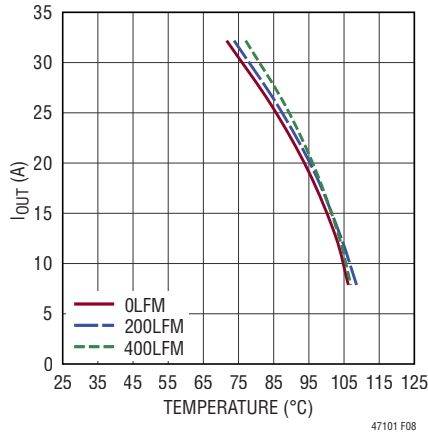

Figure 8. Derating, 4-Channel Paralleled V_{IN} = 5V, V_{OUT} = 0.5V DC3164A-B Demo Board

Figure 9. Derating, 4-Channel Paralleled V_{IN} = 3.3V, V_{OUT} = 0.8V DC3164A-B Demo Board

Figure 10. Derating, 4-Channel Paralleled V_{IN} = 5V, V_{OUT} = 0.8V DC3164A-B Demo Board
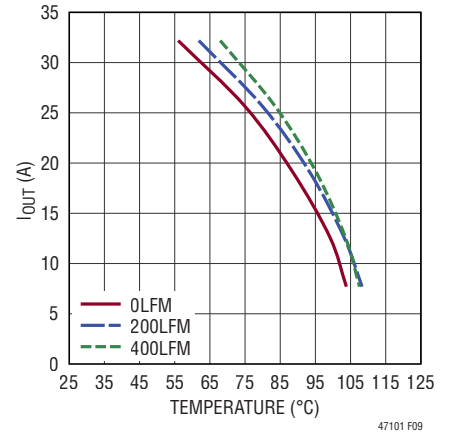

Figure 11. Derating, 4-Channel Paralleled V_{IN} = 3.3V, V_{OUT} = 1V DC3164A-B Demo Board

Figure 12. Derating, 4-Channel Paralleled V_{IN} = 5V, V_{OUT} = 1V DC3164A-B Demo Board

Figure 13. Derating, 4-Channel Paralleled V_{IN} = 3.3V, V_{OUT} = 1.2V DC3164A-B Demo Board
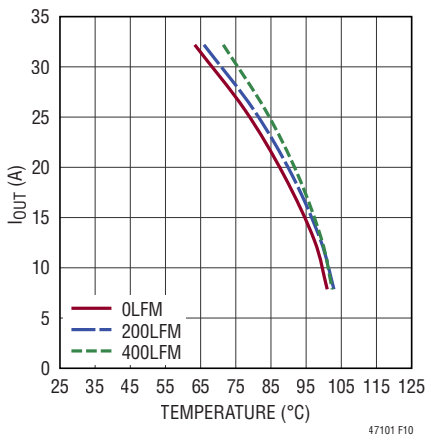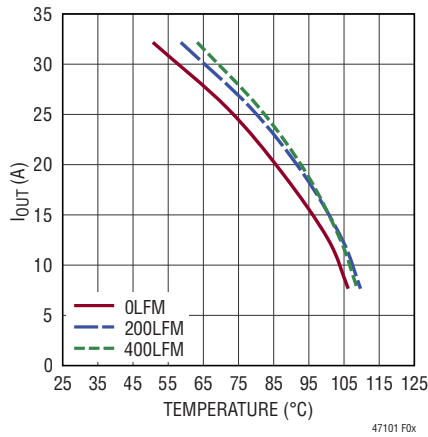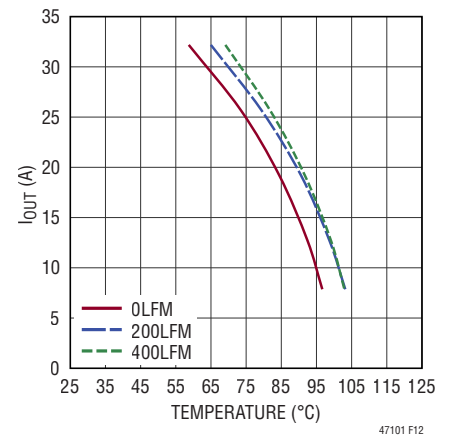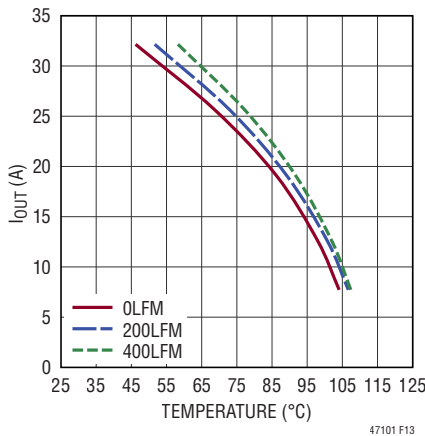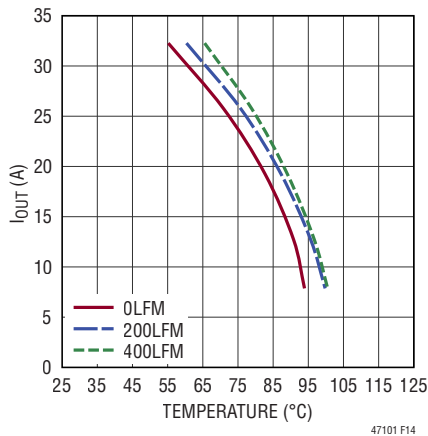

Figure 14. Derating, 4-Channel Paralleled V_{IN} = 5V, V_{OUT} = 1.2V DC3164A-B Demo Board
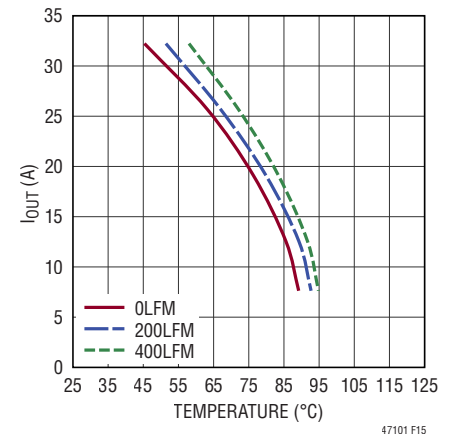

Figure 15. Derating, 4-Channel Paralleled V_{IN} = 5V, V_{OUT} = 1.5V DC3164A-B Demo Board

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Table 5. 0.5V Output

DERATING CURVE	V_IN (V)	POWER LOSS CURVE	AIRFLOW (LFM)	HEAT SINK	θ_JA (°C/W)
Figure 7, Figure 8	3.3, 5	Figure 5, Figure 6	0	None	11
Figure 7, Figure 8	3.3, 5	Figure 5, Figure 6	200	None	9
Figure 7, Figure 8	3.3, 5	Figure 5, Figure 6	400	None	10

Table 6. 0.8V Output

DERATING CURVE	V_IN (V)	POWER LOSS CURVE	AIRFLOW (LFM)	HEAT SINK	θ_JA (°C/W)
Figure 9, Figure 10	3.3, 5	Figure 5, Figure 6	0	None	14
Figure 9, Figure 10	3.3, 5	Figure 5, Figure 6	200	None	10
Figure 9, Figure 10	3.3, 5	Figure 5, Figure 6	400	None	11

Table 7. 1.0V Output

DERATING CURVE	V_IN (V)	POWER LOSS CURVE	AIRFLOW (LFM)	HEAT SINK	θ_JA (°C/W)
Figure 11, Figure 12	3.3, 5	Figure 5, Figure 6	0	None	12
Figure 11, Figure 12	3.3, 5	Figure 5, Figure 6	200	None	9
Figure 11, Figure 12	3.3, 5	Figure 5, Figure 6	400	None	9

Table 8. 1.2V Output

DERATING CURVE	V_IN (V)	POWER LOSS CURVE	AIRFLOW (LFM)	HEAT SINK	θ_JA (°C/W)
Figure 13, Figure 14	3.3, 5	Figure 5, Figure 6	0	None	12
Figure 13, Figure 14	3.3, 5	Figure 5, Figure 6	200	None	9
Figure 13, Figure 14	3.3, 5	Figure 5, Figure 6	400	None	9

Table 9. 1.5V Output

DERATING CURVE	V_IN (V)	POWER LOSS CURVE	AIRFLOW (LFM)	HEAT SINK	θ_JA (°C/W)
Figure 15	5	Figure 5, Figure 6	0	None	12
Figure 15	5	Figure 5, Figure 6	200	None	11
Figure 15	5	Figure 5, Figure 6	400	None	10

Table 10. Output Voltage Response vs Component Matrix, 6A to 8A Load Step Typical Measured Values, Freq = 1.5MHz

V_IN (V)	V_OUT (V)	C_IN CERAMIC (µF)	C_OUT1,2,3,4 CERAMIC (µF)	C_FF (pF)	PEAK-PEAK DERIVATION (mV)	LOAD STEP (A)	LOAD STEP SLEW RATE (A/µs)	R_FB (kΩ)	COMPENSATION
2.5	0.5	22 ×2 + 47	22 + 47 + 100	68	42.2	2	2	Open	Module Internal Compensation
3.3	0.5	22 ×2 + 47	22 + 47 + 100	68	44.9	2	2	Open	Module Internal Compensation
5	0.5	22 ×2 + 47	22 + 47 + 100	68	48.9	2	2	Open	Module Internal Compensation
5.5	0.5	22 ×2 + 47	22 + 47 + 100	68	49.5	2	2	Open	Module Internal Compensation
2.5	0.8	22 ×2 + 47	22 + 47 + 100	68	54.9	2	2	16.5	Module Internal Compensation
3.3	0.8	22 ×2 + 47	22 + 47 + 100	68	56.9	2	2	16.5	Module Internal Compensation
5	0.8	22 ×2 + 47	22 + 47 + 100	68	60.3	2	2	16.5	Module Internal Compensation
5.5	0.8	22 ×2 + 47	22 + 47 + 100	68	60.3	2	2	16.5	Module Internal Compensation
2.5	1	22 ×2 + 47	22 + 47 + 100	68	58.2	2	2	10	Module Internal Compensation
3.3	1	22 ×2 + 47	22 + 47 + 100	68	59.6	2	2	10	Module Internal Compensation

APPLICATIONS INFORMATION

Table 10. Output Voltage Response vs Component Matrix, 6A to 8A Load Step Typical Measured Values, Freq = 1.5MHz

V_{IN} (V)	V_{OUT} (V)	C_{IN} CERAMIC (µF)	$C_{OUT1,2,3,4}$ CERAMIC (µF)	C_{FF} (pF)	PEAK-PEAK DERIVATION (mV)	LOAD STEP (A)	LOAD STEP SLEW RATE (A/µs)	R_{FB} (kΩ)	COMPENSATION
5	1	22 ×2 + 47	22 + 47 + 100	68	62.9	2	2	10	Module Internal Compensation
5.5	1	22 ×2 + 47	22 + 47 + 100	68	61.6	2	2	10	Module Internal Compensation
2.5	1.2	22 ×2 + 47	22 + 47 + 100	68	71.6	2	2	7.15	Module Internal Compensation
3.3	1.2	22 ×2 + 47	22 + 47 + 100	68	73	2	2	7.15	Module Internal Compensation
5	1.2	22 ×2 + 47	22 + 47 + 100	68	79	2	2	7.15	Module Internal Compensation
5.5	1.2	22 ×2 + 47	22 + 47 + 100	68	82	2	2	7.15	Module Internal Compensation
2.5	1.5	22 ×2 + 47	22 + 47 + 100	68	78	2	2	4.99	Module Internal Compensation
3.3	1.5	22 ×2 + 47	22 + 47 + 100	68	80	2	2	4.99	Module Internal Compensation
5	1.5	22 ×2 + 47	22 + 47 + 100	68	90	2	2	4.99	Module Internal Compensation
5.5	1.5	22 ×2 + 47	22 + 47 + 100	68	90	2	2	4.99	Module Internal Compensation

Safety Considerations

The LTM4710-1 modules do not provide galvanic isolation from V_{IN} to V_{OUT}. There is no internal fuse. If required, a slow blow fuse with a rating twice the maximum input current must be provided to protect each unit from catastrophic failure. The device does support thermal shutdown and overcurrent protection.

Layout Checklist/Example

The high integration of LTM4710-1 makes the PCB board layout very simple and easy. However, to optimize its electrical and thermal performance, some layout considerations are still necessary.

- Use large PCB copper areas for high current paths, including V_{IN}, GND and V_{OUT}. It helps to minimize the PCB conduction loss and thermal stress.

- Place high-frequency ceramic input and output capacitors next to the V_{IN}, GND and V_{OUT} pins to minimize high-frequency noise.

- Place a dedicated power ground layer underneath the unit.

- To minimize the via conduction loss and reduce module thermal stress, use multiple vias for interconnection between top layer and other power layers.

- Do not put via directly on the pad, unless they are capped or plated over.

- Use a separated AGND ground copper area for components connected to signal pins. See AGND in Figure 17.

- For parallel modules, tie the V_{OUT}, FB, and COMP pins together. Use an internal layer to closely connect these pins together. The SSTT pin should NOT be tied together for temperature monitoring of each silicon independently.

- Bring out test points on the signal pins for monitoring.

- Solder mask-defined pin pads are recommended.

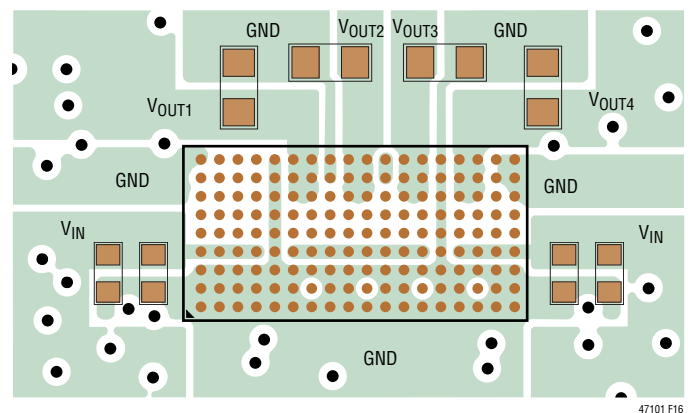Figure 16 gives a good example of the recommended layout.
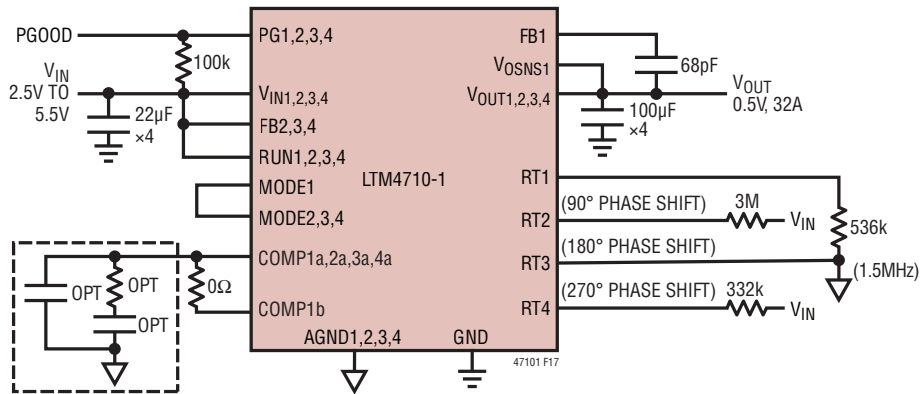

47101 F16

Figure 16. Recommended PCB Layout

TYPICAL APPLICATIONS

PINS NOT SHOWN IN THIS CIRCUIT: SSTT, SW

Figure 17. Paralleled Single Output, 32A DC/DC μModule Regulator
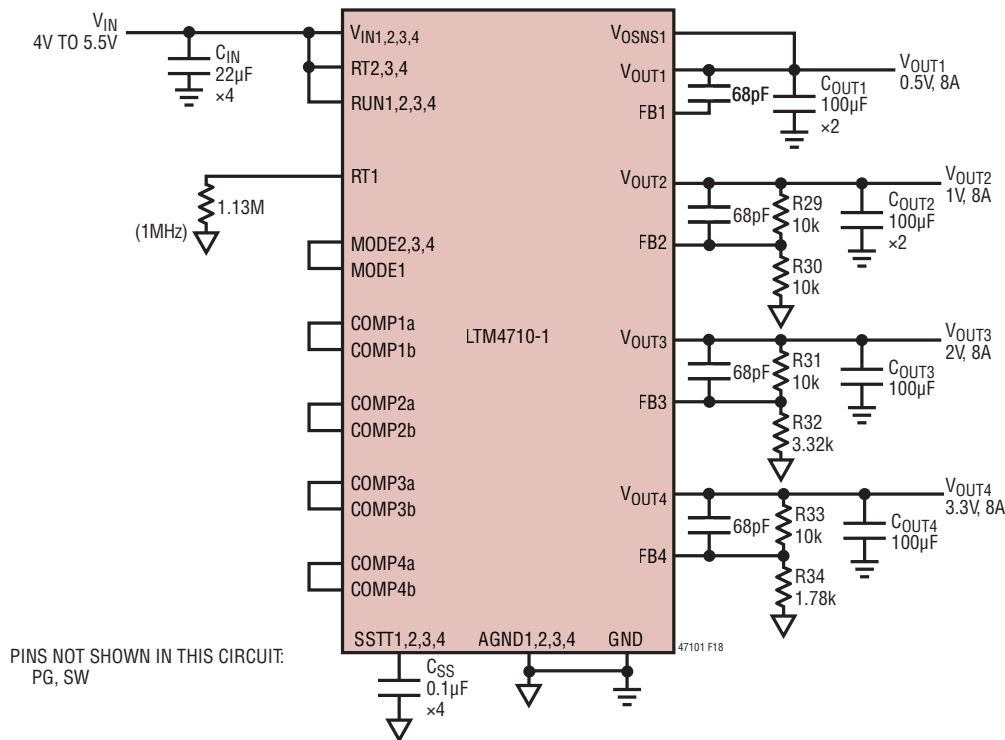
Figure 18. 0.5V, 8A; 1V, 8A; 2V, 8A; and 3.3V, 8A Outputs from 4V to 5.5V Input, Switching Frequency Synchronized

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TYPICAL APPLICATION

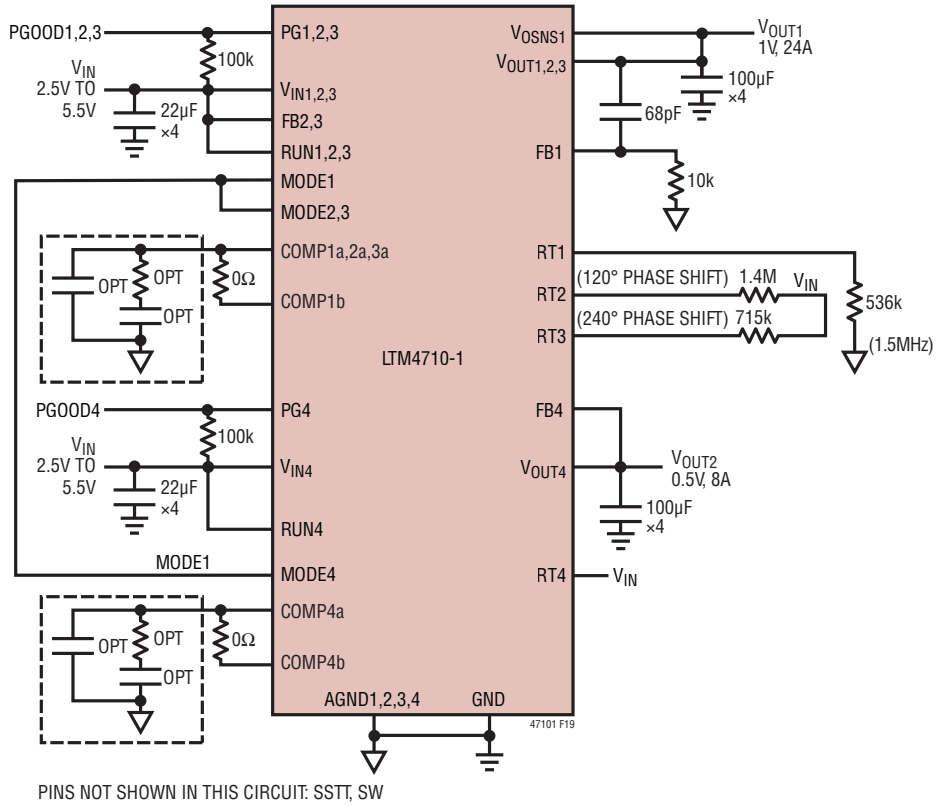PINS NOT SHOWN IN THIS CIRCUIT: SSTT, SW

Figure 19. 1V, 24A; 0.5V, 8A; Outputs from 2.5V to 5.5V Input
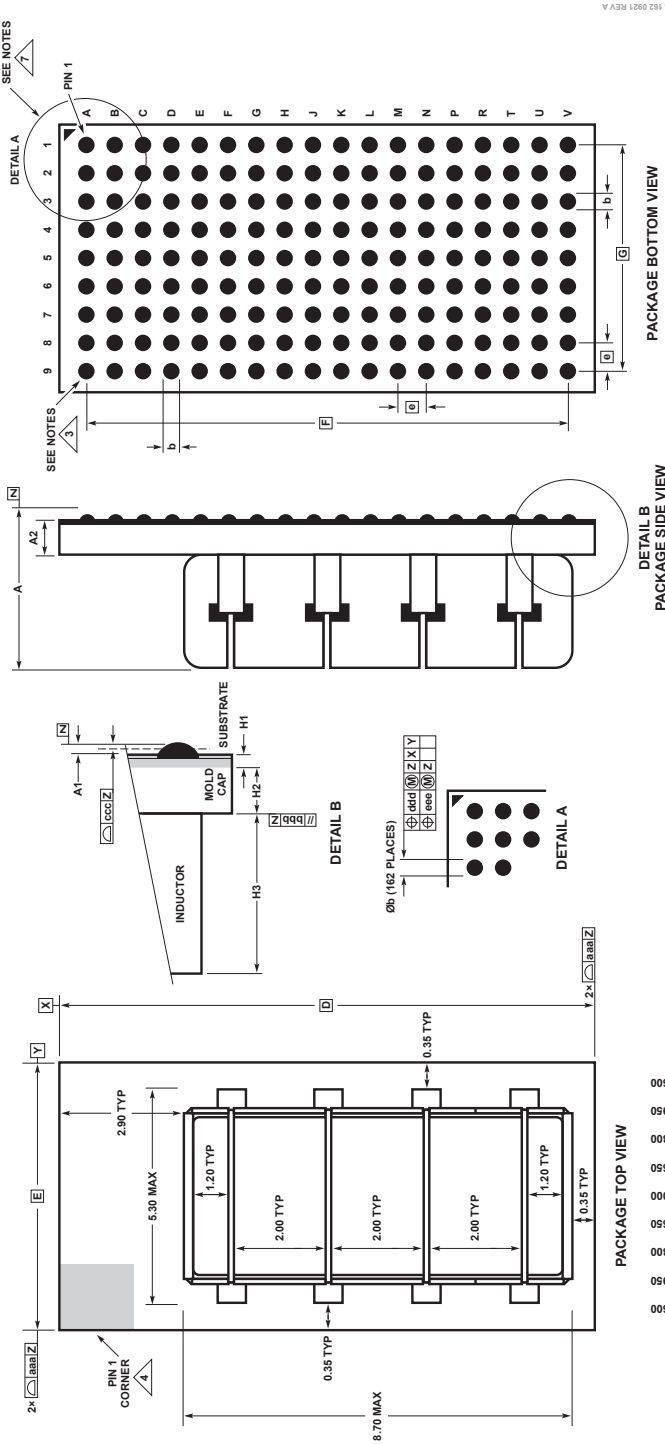
PACKAGE PINOUT DESCRIPTION

⚠ **PACKAGE ROW AND COLUMN LABELING MAY VARY AMONG µModule PRODUCTS. REVIEW EACH PACKAGE LAYOUT CAREFULLY.**

PIN	PIN NAME	PIN	PIN NAME	PIN	PIN NAME	PIN	PIN NAME	PIN	PIN NAME	PIN	PIN NAME	PIN	PIN NAME
A9	GND	B9	NC	C9	NC	D9	V_{IN1}	E9	GND	F9	V_{OUT1}		
A8	NC	B8	NC	C8	NC	D8	AGND1	E8	GND	F8	V_{OUT1}		
A7	NC	B7	NC	C7	NC	D7	V_{OSNS1}	E7	GND	F7	V_{OUT1}		
A6	FB1	B6	COMP1b	C6	COMP1a	D6	RT1	E6	GND	F6	FB2		
A5	RUN1	B5	SSTT1	C5	PG1	D5	MODE1	E5	GND	F5	RUN2		
A4	V_{IN1}	B4	V_{IN1}	C4	V_{IN1}	D4	V_{IN1}	E4	GND	F4	V_{IN2}		
A3	GND	B3	GND	C3	GND	D3	GND	E3	GND	F3	GND		
A2	GND	B2	GND	C2	GND	D2	GND	E2	GND	F2	GND		
A1	GND	B1	GND	C1	GND	D1	GND	E1	GND	F1	GND		
G9	V_{OUT1}	H9	GND	J9	V_{OUT2}	K9	V_{OUT2}	L9	GND	M9	V_{OUT3}		
G8	V_{OUT1}	H8	GND	J8	V_{OUT2}	K8	V_{OUT2}	L8	GND	M8	V_{OUT3}		
G7	V_{OUT1}	H7	AGND2	J7	V_{OUT2}	K7	V_{OUT2}	L7	AGND3	M7	V_{OUT3}		
G6	COMP2b	H6	COMP2a	J6	RT2	K6	FB3	L6	COMP3b	M6	COMP3a		
G5	SSTT2	H5	PG2	J5	MODE2	K5	RUN3	L5	SSTT3	M5	PG3		
G4	V_{IN2}	H4	V_{IN2}	J4	V_{IN2}	K4	V_{IN3}	L4	V_{IN3}	M4	V_{IN3}		
G3	GND	H3	GND	J3	GND	K3	GND	L3	GND	M3	GND		
G2	SW1	H2	GND	J2	GND	K2	SW2	L2	GND	M2	GND		
G1	GND	H1	GND	J1	GND	K1	GND	L1	GND	M1	GND		
N9	V_{OUT3}	P9	GND	R9	V_{OUT4}	T9	V_{OUT4}	U9	GND	V9	GND		
N8	V_{OUT3}	P8	GND	R8	V_{OUT4}	T8	V_{OUT4}	U8	GND	V8	GND		
N7	V_{OUT3}	P7	GND	R7	V_{OUT4}	T7	V_{OUT4}	U7	AGND4	V7	GND		
N6	RT3	P6	GND	R6	FB4	T6	COMP4b	U6	COMP4a	V6	RT4		
N5	MODE3	P5	GND	R5	RUN4	T5	SSTT4	U5	PG4	V5	MODE4		
N4	V_{IN3}	P4	GND	R4	V_{IN4}	T4	V_{IN4}	U4	V_{IN4}	V4	V_{IN4}		
N3	GND	P3	GND	R3	GND	T3	GND	U3	GND	V3	GND		
N2	SW3	P2	GND	R2	GND	T2	SW4	U2	GND	V2	GND		
N1	GND	P1	GND	R1	GND	T1	GND	U1	GND	V1	GND		

PACKAGE DESCRIPTION

LGA Package
162-Lead (6mm × 12mm × 3.54mm)
(Reference DWG# 05-08-7101 Rev A)

PACKAGE BOTTOM VIEW

PACKAGE TOP VIEW

DETAIL A

DETAIL B
PACKAGE SIDE VIEW

SUGGESTED PCB LAYOUT
TOP VIEW

PACKAGE IN TRAY LOADING ORIENTATION

BGA 162 0921 REV A

NOTES:
1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M-1994
2. ALL DIMENSIONS ARE IN MILLIMETERS
3. LAND DESIGNATION PER JEP95
4. DETAILS OF PIN 1 IDENTIFIER ARE OPTIONAL, BUT MUST BE LOCATED WITHIN THE ZONE INDICATED. THE PIN 1 IDENTIFIER MAY BE EITHER A MOLD OR MARKED FEATURE
5. PRIMARY DATUM -Z- IS SEATING PLANE
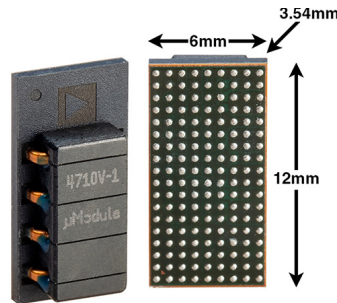6. PACKAGE ROW AND COLUMN LABELING MAY VARY AMONG µModule PRODUCTS. REVIEW EACH PACKAGE LAYOUT CAREFULLY

		DIMENSIONS		
SYMBOL	MIN	NOM	MAX	NOTES
A	3.21	3.54	3.87	
A1			0.08	PAD HT
A2	0.86	0.95	1.04	
b	0.32	0.35	0.38	PAD DIMENSION
D		12.00		
E		6.00		
e		0.65		
F		11.05		
G		5.20		
H1		0.25 REF		SUBSTRATE THK
H2		0.70 REF		MOLD CAP HT
H3	2.30	2.525	2.75	INDUCTOR HT
aaa			0.15	
bbb			0.10	
ccc			0.20	
ddd			0.25	
eee			0.10	

LTMXXXX
µModule

COMPONENT
PIN 1

TRAY PIN 1
BEVEL
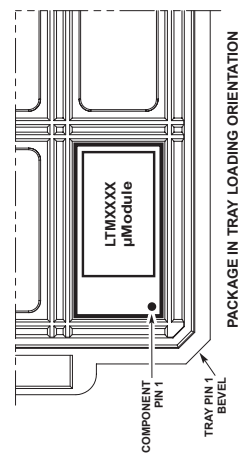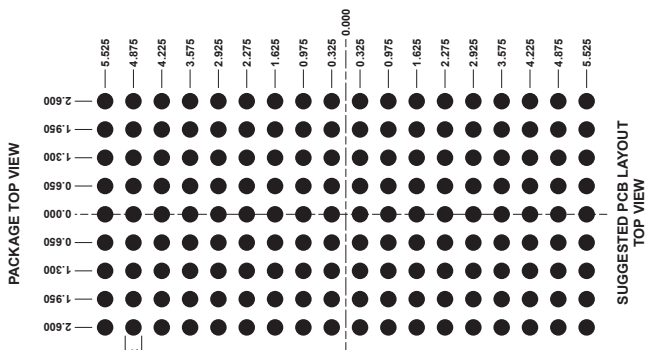
REVISION HISTORY

REV	DATE	DESCRIPTION	PAGE NUMBER
0	07/23	Initial Release.	—
A	04/24	Updated Typical Application: V_{OUT} to 1.2V/32A.	1

PACKAGE PHOTOS Part marking is either ink mark or laser mark

6mm

3.54mm

12mm

DESIGN RESOURCES

SUBJECT	DESCRIPTION	
µModule Design and Manufacturing Resources	Design: • Selector Guides • Demo Boards and Gerber Files • Free Simulation Tools	Manufacturing: • Quick Start Guide • PCB Design, Assembly and Manufacturing Guidelines • Package and Board Level Reliability
µModule Regulator Products Search	1. Sort table of products by parameters and download the result as a spread sheet. 2. Search using the Quick Power Search parametric table. Quick Power Search INPUT | $V_{in}(Min)$ [ ] V $V_{in}(Max)$ [ ] V OUTPUT | V_{Out} [ ] V I_{out} [ ] A FEATURES | ☐ Low EMI ☐ Ultrathin ☐ Internal Heat Sink Multiple Outputs Search	
Digital Power System Management	Analog Devices' family of digital power supply management ICs are highly integrated solutions that offer essential functions, including power supply monitoring, supervision, margining and sequencing, and feature EEPROM for storing user configurations and fault logging.	

RELATED PARTS

PART NUMBER	DESCRIPTION	COMMENTS
LTM4691	Low V_{IN}, Ultrathin, Dual 2A µModule Regulator	$2.25V \le V_{IN} \le 3.6V$, $0.5V \le V_{OUT} \le 2.5V$, 3mm × 4mm × 1.18mm LGA, 3mm × 4mm × 1.48mm BGA
LTM4693	Low V_{IN}, Ultrathin, 2A Buck-Boost µModule Regulator	$2.6V \le V_{IN} \le 5.5V$, $1.8V \le V_{OUT} \le 5.5V$, 3.5mm × 4mm × 1.25mm LGA
LTM4663	Ultrathin, 1.5A µModule TEC Controller	$2.7V \le V_{IN} \le 5.5V$, 3.5mm × 4mm × 1.3mm LGA
LTM4658	Low V_{IN}, 10A µModule Regulator	$2.25V \le V_{IN} \le 5.5V$, $0.5V \le V_{OUT} \le V_{IN}$, 4mm × 4mm × 4.32mm LGA
LTM4670	Low V_{IN}, Quad 10A µModule Regulator	$2.25V \le V_{IN} \le 5.5V$, $0.5V \le V_{OUT} \le V_{IN}$, 7.5mm × 15mm × 4.65mm BGA
LTM4611	Ultralow V_{IN}, 15A µModule Regulator	$1.5V \le V_{IN} \le 5.5V$, $0.8V \le V_{OUT} \le 5V$, 15mm × 15mm × 4.32mm LGA
LTM4643	Low V_{IN} with External Bias Voltage, Quad 3A µModule Regulator	$2.375V \le V_{IN} \le 20V$, $0.6V \le V_{OUT} \le 3.3V$, 9mm × 15mm × 1.82mm BGA, 9mm × 15mm × 2.42mm BGA
LTM4702	16V_{IN}, 8A Ultralow Noise Silent Switcher µModule Regulator	$3V \le V_{IN} \le 16V$, $0.3V \le V_{OUT} \le 5.7V$, 6.25mm × 6.25mm × 5.07mm BGA
LTM8060	Quad 40V_{IN}, Silent Switcher µModule Regulator with Configurable 3A Output Array	$3V \le V_{IN} \le 40V$, $0.8V \le V_{OUT} \le 8V$, 11.9mm × 16mm × 3.32mm BGA
LTM8051	Quad 40V_{IN} Silent Switcher µModule Regulator with Configurable 1.2A Output Array	$3V \le V_{IN} \le 40V$, $0.8V \le V_{OUT} \le 8V$, 6.25mm × 11.25mm × 2.22mm BGA

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ANALOG DEVICES